

1 Introduction

Inverter is the basic unit when designing the complicated CMOS logic. So it's important to do inverter simulation due to better acknowledgement about more complex and obscure DIC coming later.

2 Lab Procedures

This lab is also based on using the Predictive Technology Model (PTM) to evaluate the DC characteristics of 16nm bulk Si-MOSFETs and 10nm multi-gate (MG) FinFETs. And the simulation settings are shown as follows:

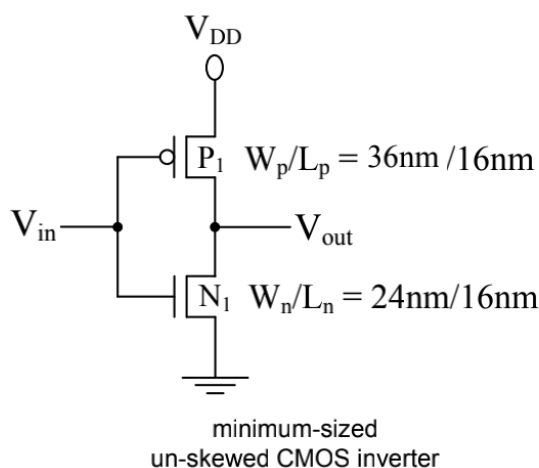
1. $L_g = 14 \text{ nm}$ for FinFETs while $L_g = 16 \text{ nm}$ for bulk Si-MOSFETs
2. Supply voltage is 0.65 V for FinFETs and 0.7 V for bulk Si-MOSFETs
3. Simulation temperature $T = 25^\circ \text{ C}$

I connect the output load to the ground instead of floating in task1 and task2. I don't think there's nothing bad after I confirm with the TA that the output pin should be floating when I was doing task3. The result or more specifically, the conclusion in this lab won't change at more. If TA want data simulated in float connection, just contact me.

2.1 Measurement of C_g

The basic structure of t an inverter is shown as belows (reference: slides page6)

➤ 1X, 32X of minimum sized inverter



Minimum Sized Inv	PMOS	NMOS
W	36n	24n
L	16n	16n
You are free to change these widths, but in the minimum tuning step of 4nm		
Minimum Sized Inv	PMOS	NMOS
Fin number	1	1
L	14n	14n
Design the fin number to ensure balanced driving current in pull-up and pull-down network		

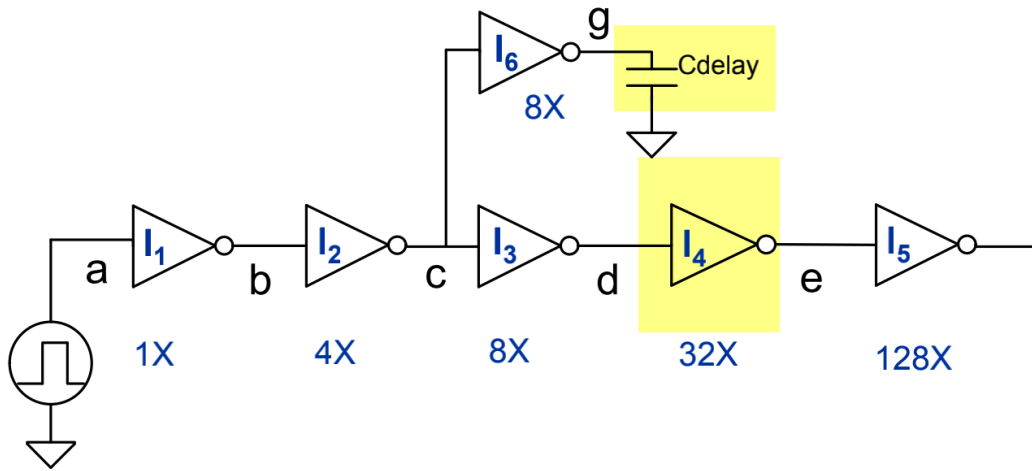
As we can see, the $\lambda = 8 \text{ nm}$ due to the process. So the voltage $v_{dd} = 0.7 \text{ V}$ for bulk silicon and 0.65 V for FinFet. And we can assume that the unit inverter has a symmetrical propagation delay which means

$t_{pLH} = t_{pHL}$. We can derive the standard inverter size under the specific process shown as the right figure.

The basic $\frac{(W/l)_p}{(W/l)_n} = 1.5$ (notice: not equals to 2 as we learned in class). Overriding the same process of

analysis, we can ensure the $\frac{(fin.n)_p}{(fin.n)_n} = 1.0$ to perform a minimum FinFet inverter.

We can estimate the C_g as the following figure:



The proof of the method is simple, take the $32 \times$ inverter shown in the figure as an example. Due to the pre-driving network is the same. So if the $t_{c \rightarrow g} = t_{c \rightarrow d}$, we can estimate the $C_g = C_{delay}$. Totally the same as the FinFet!

So the code is as belows:

```

1 .TITLE bulk_c_32
2 .lib "/LAB1_LIB/BULK/models" ptm16hp_bulk
3
4 .option post
5 .global vdd gnd
6 .temp 25
7
8 .param supply = 0.7V
9 .param length = 16nm
10 .param n_width = 24nm
11 .param p_width = 36nm
12 .param Cdelay = 1.8 fF
13
14
15 .subckt inv in out l=16nm w1=24nm w2=36nm
16 xnmos out in gnd gnd nfet l=length w=w1
17 xpmos out in vdd vdd pfet l=length w=w2

```

```

18 .ends
19
20 x1 vin1 vout1 inv
21 x2 vout1 vout2 inv w1='4*24n' w2='4*36n'
22 x3 vout2 vout3 inv w1='8*24n' w2='8*36n'
23 x4 vout3 vout4 inv w1='32*24n' w2='32*36n'
24 x5 vout4 vout5 inv w1='128*24n' w2='128*36n'
25 x6 vout2 g inv w1='8*24n' w2='8*36n'
26 C g gnd Cdelay
27
28 vs vin1 gnd pulse(0,0.7,1ns,50ps,50ps,1ns,2ns)
29 vdd vdd gnd supply
30
31 .TRAN 1ns 9ns sweep Cdelay 1.78fF 1.8fF 0.005fF
32
33 .measure tran tpLH1
34 +trig V(vout2)='0.5*supply' fall=2
35 +targ V(g)='0.5*supply' rise=2
36 .measure tran tpHL1
37 +trig V(vout2)='0.5*supply' rise=2
38 +targ V(g)='0.5*supply' fall=2
39 .measure tran tpLH2
40 +trig V(vout2)='0.5*supply' fall=2
41 +targ V(vout3)='0.5*supply' rise=2
42 .measure tran tpHL2
43 +trig V(vout2)='0.5*supply' rise=2
44 +targ V(vout3)='0.5*supply' fall=2
45 .measure tp1 param=(tpLH1+tpHL1)/2'
46 .measure tp2 param=(tpLH2+tpHL2)/2'
47
48
49 .end

```

t1 bulk c32.sp

By using the same idea, we can derive the **FinFet** simulation code shown as belows:

```

1 .TITLE finfet_c_1
2 .lib "../LAB1_LIB/FINFET/models" ptm16hp
3
4 .option post
5 .global vdd gnd
6 .temp 25
7
8 .param supply = 0.65V
9 .param length = 14nm
10 * .param n_width = 24nm
11 * .param p_width = 36nm
12 .param Cdelay = 1.8fF
13
14
15 .subckt inv in out l=length n1=1 n2=1
16 xnmos out in gnd gnd nfet l=length NFIN=n1
17 xpmos out in vdd vdd pfet l=length NFIN=n2

```

```

18 .ends
19
20 x1 vin1 vout1 inv
21 x2 vout1 vout2 inv n1='4*1' n2='4*1'
22 x3 vout2 vout3 inv n1='8*1' n2='8*1'
23 x4 vout3 vout4 inv
24 x5 vout4 vout5 inv n1='128*1' n2='128*1'
25 x6 vout2 g inv n1='8*1' n2='8*1'
26 C g gnd Cdelay
27
28 vs vin1 gnd pulse(0,0.7,1ns,50ps,50ps,1ns,2ns)
29 vdd vdd gnd supply
30
31 .TRAN 1ns 9ns sweep Cdelay 1.5fF 2fF 0.05fF
32
33 .measure tran tpLH1
34 +trig V(vout2)='0.5*supply' fall=2
35 +targ V(g)='0.5*supply' rise=2
36 .measure tran tpHL1
37 +trig V(vout2)='0.5*supply' rise=2
38 +targ V(g)='0.5*supply' fall=2
39 .measure tran tpLH2
40 +trig V(vout2)='0.5*supply' fall=2
41 +targ V(vout3)='0.5*supply' rise=2
42 .measure tran tpHL2
43 +trig V(vout2)='0.5*supply' rise=2
44 +targ V(vout3)='0.5*supply' fall=2
45 .measure tp1 param=(tpLH1+tpHL1)/2'
46 .measure tp2 param=(tpLH2+tpHL2)/2'
47
48
49 .end

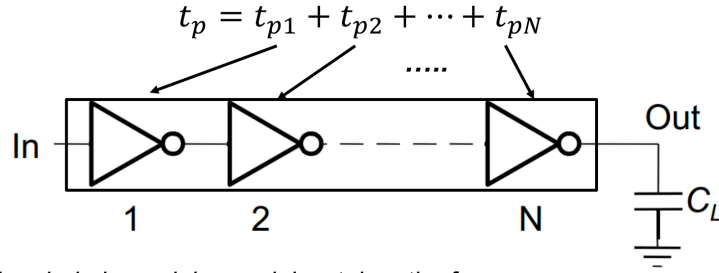
```

t1 finfet c1.sp

2.2 Delay Optimization of Inverter Chain

For a given input capacitance (minimum sized inverter) and Cload (256x of minimum sized inverter), design the inverter chain to minimize the delay for both bulk silicon and FinFET

We usually simulate the idea like this figure shown as belows:



When the chain has minimum delay, t_p has the form:

$$t_p = Nt_{p0} \left(1 + \frac{f}{\gamma}\right) \quad f^N = F = \frac{C_L}{C_{g,1}}$$

In fact, t_p can be transformed to a function only related to f :

$$t_p = Nt_{p0} \left(1 + \frac{f}{\gamma}\right) = \frac{t_{p0} \ln F}{\gamma} \left(\frac{f}{\ln f} + \frac{\gamma}{\ln f}\right) \xrightarrow{\text{To minimize } t_p} \frac{\partial t_p}{\partial f} = \frac{t_{p0} \ln F}{\gamma} \cdot \frac{\ln f - 1 - \frac{\gamma}{f}}{\ln^2 f} = 0$$

$$f_{opt} = 3.6 \text{ for } \gamma = 1$$

$$f = \exp(1 + \gamma/f)$$

Theoretically, we can derive the formula of the **optimal** fan-out for each inverter in a single inverter chain is 3.6 due to the formulation shown above. Usually we choose 4 or 3 due to the circumstances. The formula to calculate the levels of a chain is $N = \frac{\ln F}{\ln f}$. There is a detail we must pay enough attention to is the bulk's parameter, width, can be a float. In contrast, FinFet's parameter, FIN number, should definitely be an **integer**. So I choose 2,3,4,5 for f value and 2-level,3-level,5-level for N to figure out each delay for bulk and choose 3,4 for f value, 5-level,6-level for N for FINFET.

The complete process is:

1. Add a DC supply and a pulse generator for the input signal. Set the following parameters for the pulse generator and I override the PULSE used in task1 that I can easily observe and measure the delay from the simulated MT0 file.
2. Insert appropriate number of inverters and determine the sizes of each inverter between the minimum-sized inverter and the capacitor load so that the delay from the input signal to the output at the capacitor is minimized
3. (Be careful!) For bulk silicon, the minimum tuning step of width of each transistor is 4nm. For FinFET, the fin number of each transistor needs to be integer.

I just take the optimal chain design for bulk and FINFET as an example, the code is shown as below:

```

1
2 x1 vin1 vout1 inv
3 x2 vout1 vout2 inv w1='4*24n' w2='4*36n'
4 x3 vout2 vout3 inv w1='16*24n' w2='16*36n'
5 x4 vout3 vout4 inv w1='64*24n' w2='64*36n'
6 xload vout4 gnd inv w1='256*24n' w2='256*36n'
7
8 vs vin1 gnd pulse(0,0.7,1ns,50ps,50ps,1ns,2ns)
9 vdd vdd gnd supply
10
11 .TRAN 1ns 9ns

```

```

12
13 .measure tran tpLH
14 +trig V(vin1)='0.5*supply' fall=2
15 +targ V(vout4)='0.5*supply' rise=2
16 .measure tran tpHL
17 +trig V(vin1)='0.5*supply' rise=2
18 +targ V(vout4)='0.5*supply' fall=2
19
20 .measure tp param='(tpLH+tpHL)/2'

```

t2 bulk .sp (core code)

```

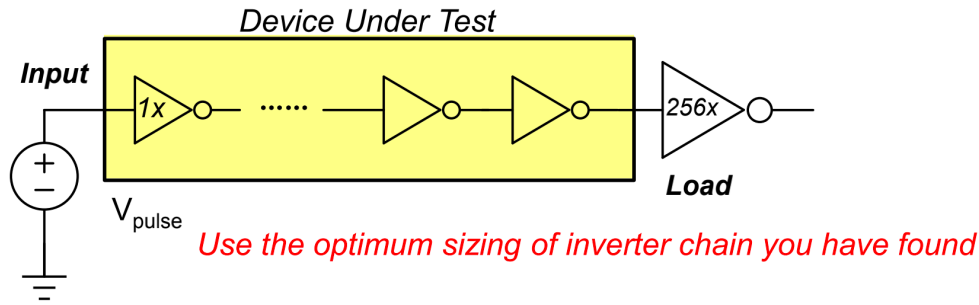
1
2 .subckt inv in out l=length n1=1 n2=1
3 xnmos out in gnd gnd nfet l=length NFIN=n1
4 xpmos out in vdd vdd pfet l=length NFIN=n2
5 .ends
6
7 x1 vin1 vout1 inv
8 x2 vout1 vout2 inv n1=4 n2=4
9 x3 vout2 vout3 inv n1=16 n2=16
10 x4 vout3 vout4 inv n1=64 n2=64
11 xload vout4 gnd inv n1=256 n2=256
12
13 vs vin1 gnd pulse(0,0.65,1ns,50ps,50ps,1ns,2ns)
14 vdd vdd gnd supply
15
16 .TRAN 1ns 9ns
17
18 .measure tran tpLH
19 +trig V(vin1)='0.5*supply' fall=2
20 +targ V(vout4)='0.5*supply' rise=2
21 .measure tran tpHL
22 +trig V(vin1)='0.5*supply' rise=2
23 +targ V(vout4)='0.5*supply' fall=2
24
25 .measure tp param='(tpLH+tpHL)/2'

```

t2 finfet .sp (core code)

2.3 Power of Inverter Chain

Measure the power of inverter chain Only include the power consumption of inverter chain. Apply a pulse voltage on the input node and measure the power averaging for multiple cycles.



Hint:

1. We can use two different power supply sources for the DUT inverter and other parts (for example, use VDD1 for the DUT inverter while using VDD2 for the other parts)
2. We can use the *.MEASURE* command to measure the power consumption. For example to measure the power of the circuit from VDD:

```
1 .MEASURE TRAN avgpower AVG P(VDD1) FROM=1ns TO=80ns
```

This shows how we can get the average power for the inverter chain is that separating the Vdd to different parts and use *.measure* to check a single voltage supply.

In this task, I just let the output of the load inverter to be float. The core code is shown as below:

```
1
2 .param supply = 0.7V
3 .param supplyload = 0.7v
4 .param length = 16nm
5 .param n_width = 24nm
6 .param p_width = 36nm
7
8 .subckt inv in out l=length w1=24nm w2=36nm
9 xnmos out in gnd gnd nfet l=length w=w1
10 xpmos out in vdd vdd pfet l=length w=w2
11 .ends
12
13 .subckt invload in out l=length w1=24nm w2=36nm
14 xnmos out in gnd gnd nfet l=length w=w1
15 xpmos out in vdd2 vdd2 pfet l=length w=w2
16 .ends
17
18 x1 vin1 vout1 inv
19 x2 vout1 vout2 inv w1='4*24n' w2='4*36n'
20 x3 vout2 vout3 inv w1='16*24n' w2='16*36n'
21 x4 vout3 vout4 inv w1='64*24n' w2='64*36n'
22 xload vout4 vout5 invload w1='256*24n' w2='256*36n'
23
24 vs vin1 gnd pulse(0,0.7,1ns,50ps,50ps,1ns,2ns)
25 vdd vdd gnd supply
26 vdd2 vdd2 gnd supplyload
```

```

27
28 .TRAN 1ns 9ns
29
30 .MEASURE TRAN avgpwr AVG P(VDD) FROM=1ns TO=9ns
31
32 .end

```

t3 bulk power .sp (core code)

The **FINFET** simulation is quite similar, it is shown as belows:

```

1 .option post
2 .global vdd gnd vdd2
3 .temp 25
4
5 .param supply = 0.65V
6 .param supplyload = 0.65v
7 .param length = 14nm
8
9 .subckt inv in out l=length n1=1 n2=1
10 xmos out in gnd gnd nfet l=length NFIN=n1
11 xpmos out in vdd vdd pfet l=length NFIN=n2
12 .ends
13
14 .subckt invload in out l=length n1=1 n2=1
15 xmos out in gnd gnd nfet l=length NFIN=n1
16 xpmos out in vdd2 vdd2 pfet l=length NFIN=n2
17 .ends
18
19 x1 vin1 vout1 inv
20 x2 vout1 vout2 inv n1=4 n2=4
21 x3 vout2 vout3 inv n1=16 n2=16
22 x4 vout3 vout4 inv n1=64 n2=64
23 xload vout4 vout5 invload n1=256 n2=256
24
25 vs vin1 gnd pulse(0,0.65,1ns,50ps,50ps,1ns,2ns)
26 vdd vdd gnd supply
27 vdd2 vdd2 gnd supplyload
28
29 .TRAN 1ns 9ns
30
31 .MEASURE TRAN avgpwr AVG P(VDD) FROM=1ns TO=9ns
32
33 .end

```

t3 finfet power .sp

2.4 Optimal Vdd for Minimizing EDP

Find the optimal point of VDD to minimize the energy and delay Product.

EDP (Energy-Delay-Product) is defined as:

$$EDP = P_{average} t_{propagation}^2$$

It's quite simple since finished task2 and task3. We just need to combine the task2 and task3 code.

The core code is shown as below:

```

1 .TITLE bulk_chain
2 .lib ".LAB1_LIB/BULK/models" ptm16hp_bulk
3
4 .option post
5 .global vdd gnd vdd2
6 .temp 25
7
8 .param supply = 0.7V
9
10 .param length = 16nm
11 .param n_width = 24nm
12 .param p_width = 36nm
13
14
15
16 .subckt invload in out l=length w1=24nm w2=36nm
17 xnmos out in gnd gnd nfet l=length w=w1
18 xpmos out in vdd2 vdd2 pfet l=length w=w2
19 .ends
20
21
22 .subckt inv in out l=length w1=24nm w2=36nm
23 xnmos out in gnd gnd nfet l=length w=w1
24 xpmos out in vdd vdd pfet l=length w=w2
25 .ends
26
27 x1 vin1 vout1 inv
28 x2 vout1 vout2 inv w1='4*24n' w2='4*36n'
29 x3 vout2 vout3 inv w1='16*24n' w2='16*36n'
30 x4 vout3 vout4 inv w1='64*24n' w2='64*36n'
31 xload vout4 gnd invload w1='256*24n' w2='256*36n'
32
33 vs vin1 gnd pulse(0,0.7,1ns,50ps,50ps,1ns,2ns)
34 vdd vdd gnd supply
35 vdd2 vdd2 gnd supply
36
37
38
39 .TRAN 1ns 9ns sweep supply 0.7 1.3 0.05
40
41 .measure tran tpLH1
42 +trig V(vin1)='0.5*supply' fall=2
43 +targ V(vout1)='0.5*supply' rise=2
44 .measure tran tpHL1
45 +trig V(vin1)='0.5*supply' rise=2
46 +targ V(vout1)='0.5*supply' fall=2
47 .measure tpl param='(tpLH1+tpHL1)/2'
48
49
50 .measure tran tpLH2

```

```

51 +trig V(vout1)='0.5*supply' fall=2
52 +targ V(vout2)='0.5*supply' rise=2
53 .measure tran tpHL2
54 +trig V(vout1)='0.5*supply' rise=2
55 +targ V(vout2)='0.5*supply' fall=2
56 .measure tp2 param='(tpLH2+tpHL2)/2'
57
58
59 .measure tran tpLH3
60 +trig V(vout2)='0.5*supply' fall=2
61 +targ V(vout3)='0.5*supply' rise=2
62 .measure tran tpHL3
63 +trig V(vout2)='0.5*supply' rise=2
64 +targ V(vout3)='0.5*supply' fall=2
65 .measure tp3 param='(tpLH3+tpHL3)/2'
66
67
68 .measure tran tpLH4
69 +trig V(vout3)='0.5*supply' fall=2
70 +targ V(vout4)='0.5*supply' rise=2
71 .measure tran tpHL4
72 +trig V(vout3)='0.5*supply' rise=2
73 +targ V(vout4)='0.5*supply' fall=2
74 .measure tp4 param='(tpLH4+tpHL4)/2'
75
76 .measure tp param='tpLH1+tpLH2+tpLH3+tpLH4'
77
78 .MEASURE TRAN avgpwr AVG P(VDD) FROM=1ns TO=9ns
79
80 .measure EDP param='avgpwr*tp*tp'
81
82 .end

```

ALL you need is just combine the task3 and task 4 code into one

Due to the page limit, the FINFET optimal vdd will not displayed here, you can check them by unzipping what I upload.

3 Lab Results

3.1 Measurement of C_g

3.1.1 Minimized bulk CMOS inverter

The screenshot after t1_bulk_c1.sp

```

c_1_bulk - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
5.257e-12 4.789e-12 5.049e-12
25.0000 1
3.100e-17 4.574e-12 5.096e-12 4.841e-12
5.257e-12 4.835e-12 5.049e-12
25.0000 1
3.200e-17 4.620e-12 5.139e-12 4.841e-12
5.257e-12 4.880e-12 5.049e-12
25.0000 1
3.300e-17 4.666e-12 5.183e-12 4.841e-12
5.257e-12 4.925e-12 5.049e-12
25.0000 1
3.400e-17 4.712e-12 5.226e-12 4.841e-12
5.257e-12 4.969e-12 5.049e-12
25.0000 1
3.500e-17 4.760e-12 5.269e-12 4.843e-12
5.257e-12 5.014e-12 5.050e-12
25.0000 1
3.600e-17 4.805e-12 5.312e-12 4.843e-12
5.257e-12 5.058e-12 5.050e-12
25.0000 1
3.700e-17 4.851e-12 5.354e-12 4.843e-12
5.257e-12 5.102e-12 5.050e-12
25.0000 1
3.800e-17 4.896e-12 5.543e-12 4.843e-12
5.383e-12 5.219e-12 5.113e-12
25.0000 1
第 45 行, 第 5 列 100% Unix (LF) UTF-8

```

The C_g is about 3.6×10^{-17} F

3.1.2 32 Minimized bulk CMOS inverter

The screenshot after t1_bulk_c32.sp

```

$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE 'title bulk_c_32'
cdelay      tphl1      tphl1      tphl2
            tphl2      tp1        tp2
            temper      alter#
1.780e-15    7.083e-12  7.670e-12  7.200e-12
            7.605e-12  7.376e-12  7.403e-12
            25.0000    1
1.785e-15    7.094e-12  7.681e-12  7.200e-12
            7.605e-12  7.387e-12  7.403e-12
            25.0000    1
1.790e-15    7.104e-12  7.692e-12  7.200e-12
            7.606e-12  7.398e-12  7.403e-12
            25.0000    1
1.795e-15    7.115e-12  7.703e-12  7.200e-12
            7.606e-12  7.409e-12  7.403e-12
            25.0000    1
1.800e-15    7.125e-12  7.715e-12  7.199e-12
            7.606e-12  7.420e-12  7.403e-12
            25.0000    1

```

The C_g is about 1.79×10^{-15} F

3.1.3 Minimized FinFet CMOS inverter

The screenshot after t1_finfet_c1.sp

```

c_1_fin - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title finfet_c_1'
delay      tphi1      tphi1      tphi2
           tphi2      tp1        tp2
           temper    alter#
1.000e-16   2.477e-12   1.811e-12   2.589e-12
           1.925e-12   2.144e-12   2.257e-12
           25.0000    1
1.200e-16   2.523e-12   1.854e-12   2.578e-12
           1.906e-12   2.188e-12   2.242e-12
           25.0000    1
1.400e-16   2.513e-12   2.068e-12   2.509e-12
           2.064e-12   2.291e-12   2.286e-12
           25.0000    1
1.600e-16   2.561e-12   1.952e-12   2.514e-12
  
```

The C_g is about 1.4×10^{-16} F

3.1.4 32 Minimized bulk CMOS inverter

The screenshot after t1_finfet_c32.sp

```

c_32_fin - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
7.402e-12   7.415e-12   7.618e-12
           25.0000    1
4.600e-15   7.515e-12   7.247e-12   7.691e-12
           7.376e-12   7.381e-12   7.533e-12
           25.0000    1
4.650e-15   7.636e-12   7.113e-12   7.766e-12
           7.179e-12   7.374e-12   7.473e-12
           25.0000    1
4.700e-15   7.556e-12   7.054e-12   7.618e-12
           7.081e-12   7.305e-12   7.350e-12
           25.0000    1
4.750e-15   8.250e-12   7.601e-12   8.283e-12
           7.567e-12   7.925e-12   7.925e-12
           25.0000    1
4.800e-15   8.249e-12   7.576e-12   8.230e-12
  
```

The C_g is about 4.75×10^{-15} F

3.2 Delay Optimization of Inverter Chain

3.2.1 bulk silicon

The optimal one is $f = 4, N = 4$, shown as belows:

```

bulk_chain_4_4level - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title bulk_chain'
tph1      tph1      tp1      tph2
tph2      tp2      tph3      tph3
tp3      tph4      tph4      tp4
tp      temper      alter#
1.008e-11  1.159e-11  1.083e-11  8.566e-12
1.071e-11  9.639e-12  6.776e-12  7.645e-12
7.210e-12  6.690e-12  6.397e-12  6.543e-12
3.211e-11  25.0000  1

```

The optimal size of the chain is 4-level with f=4

The other results are also shown as below:

```

bulk_chain_2level - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title bulk_chain'
tph1      tph1      tp1      tph2
tph2      tp2      tp      temper
alter#
2.356e-11  2.372e-11  2.364e-11  2.207e-11
2.390e-11  2.298e-11  4.662e-11  25.0000
1

bulk_chain_2 - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
tph2      tp2      tph3      tph3
tp3      tph4      tph4      tp4
tph5      tph5      tp5      tph6
tph6      tp6      tph7      tph7
tp7      tph8      tph8      tp8
tp      temper      alter#
5.705e-12  7.932e-12  7.444e-12  5.968e-12
9.183e-12  7.576e-12  6.486e-12  5.230e-12
5.858e-12  4.345e-12  3.543e-12  3.944e-12
3.475e-12  4.454e-12  3.964e-12  4.305e-12
4.389e-12  4.347e-12  4.489e-12  4.427e-12
4.458e-12  4.296e-12  4.274e-12  4.285e-12
4.188e-11  25.0000  1

```

```

bulk_chain_3_5level - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title bulk_chain'
tphl      tphl      tp      temper
alter#
3.467e-11   3.477e-11   3.472e-11   25.0000
1

bulk_chain_3level - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title bulk_chain'
tphl1      tphl1      tp1      tphl2
tphl2      tp2      tphl3      tphl3
tp3      tp      temper      alter#
1.412e-11   1.385e-11   1.339e-11   1.242e-11
1.265e-11   1.254e-11   9.301e-12   9.321e-12
9.311e-12   3.523e-11   25.0000    1

bulk_chain_5 - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title bulk_chain'
tphl1      tphl1      tp1      tphl2
tphl2      tp2      tphl3      tphl3
tp3      tphl4      tphl4      tp4
tp      temper      alter#
1.358e-11   1.190e-11   1.188e-11   1.142e-11
1.018e-11   1.080e-11   8.735e-12   8.195e-12
8.465e-12   5.693e-12   5.841e-12   5.767e-12
3.691e-11   25.0000    1

```

3.2.2 FinFet

The optimal one is $f = 4, N = 4$, shown as belows:

fin_chain_4 - 记事本

— □

文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)

\$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'

.TITLE '.title finfet_chain'

tph1	tph1	tp1	tph2
tph2	tp2	tph3	tph3
tp3	tph4	tph4	tp4
tp	temper	alter#	
1.039e-11	8.286e-12	9.108e-12	8.371e-12
7.821e-12	8.096e-12	8.242e-12	7.723e-12
7.983e-12	7.292e-12	7.281e-12	7.286e-12
3.247e-11	25.0000	1	

The optimal size of the chain is 4-level with $f=4$, but we also found that 5-level FINFET delay is quite approached to the 4-level FINFET. I think both is alright, we choose 4-level for convenience later(You can check the code in the .zip)

The other results are also shown as below:

fin_chain_3 - 记事本

— □

文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)

\$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'

.TITLE '.title finfet_chain'

tph1	tph1	tp1	tph2
tph2	tp2	tph3	tph3
tp3	tph4	tph4	tp4
tph5	tph5	tp5	tp
temper	alter#		
8.786e-12	7.803e-12	7.844e-12	7.852e-12
6.902e-12	7.377e-12	6.682e-12	5.993e-12
6.338e-12	6.280e-12	5.861e-12	6.071e-12
6.079e-12	5.894e-12	5.986e-12	3.362e-11
25.0000	1		

```

bulk_chain_5 - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title bulk_chain'
tph1      tph1      tp1      tph2
tphl2     tp2      tphl3    tphl3
tp3       tphl4    tphl4    tp4
tp        temper   alter#
1.358e-11 1.190e-11 1.188e-11 1.142e-11
1.018e-11 1.080e-11 8.735e-12 8.195e-12
8.465e-12 5.693e-12 5.841e-12 5.767e-12
3.691e-11 25.0000 1

```

3.3 Power of Inverter Chain

3.3.1 bulk silicon

The result is shown as below:

```

bulk_power - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title bulk_chain'
avgpwr    temper   alter#
-8.689e-06 25.0000 1

```

In this circumstance, the power of the chain is about $8.689 \times 10^{-6} W$

3.3.2 FinFet

The result is shown as below:

```

fin_power - 记事本
文件(F) 编辑(E) 格式(O) 查看(V) 帮助(H)
$DATA1 SOURCE='HSPICE' VERSION='J-2014.09-2 64-BIT'
.TITLE '.title finfet_chain'
avgpwr    temper   alter#
-4.187e-05 25.0000 1

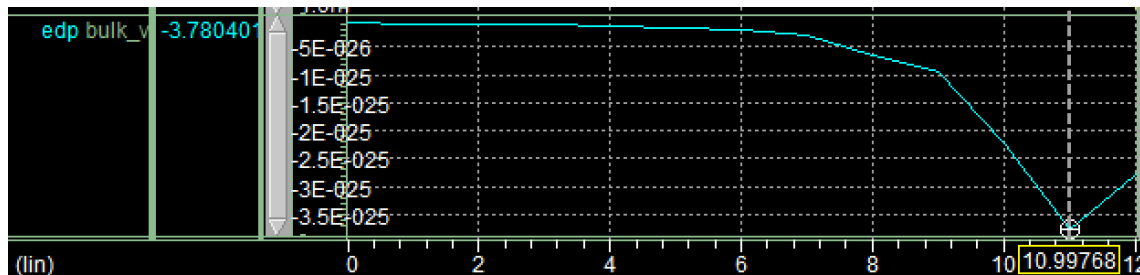
```

In this circumstance, the power of the chain is about $4.1876 \times 10^{-6} W$

3.4 Optimal Vdd for Minimizing EDP

3.4.1 bulk silicon

The waveform is shown as below:



The optimal Vdd is about 1.1V

3.4.2 FinFet

The optimal Vdd is about 0.9V

4 Technical Analysis of the Simulation Results

1. Why there is a difference between $C_g(1)$ and $C_g(32)$: I'm not sure about this, I suppose it might be some parasitic capacitance in the inverter chain. There's some capacitance which is not related to the size and due to the expansion of our sweeping it will cause some little error.
2. details about propagation delay measure: The propagation delay measurement is required to measure each stage t_p and sum them to get the result. At the very beginning I just measure the propagation delay from the input pin to the out load. But this is not correct due to the formula written in the slides. The propagation delay from the very beginning to the end may be come across a whole period which will leads to a negative t_{plh} or t_{phl} .
3. The 5-level and 4-level FINFET's propagation delay is quite closed to each other. In the resource code, I assign each level of the 5-level chain as 1,3,9,28,84,256. Due to the limitation that FIN-number is required to be an integer, we cannot assign them just as accurate value as the $f=2.5$ approxiamtely, we only can assign them as probable value. This might cause some problem due to the unequal value between each level. But I think the difference between 4-level and 5-level is quite tiny that can be ignored.
4. Power: The power is separated into 2 parts and measured by command mentioned before. This shows why we cannot design a pretty long chain. It will highly apparently increase the total power consumption and also cause a unwelcomed delay.

5 Observations and conclusions

1. More levels, more delay and power consumption.
2. Design a inverter chain is a power-efficiency trade off work. EDP is an acceptable parameter to figure out which point is the optimal one.
3. The C_g is a measurement of equal idea.